Critical N-Laplacian Stein-Weiss system in \mathbb{R}^N : Existence of solutions, asymptotic behavior, uniform estimates and regularity

P. K. Mishra

Department of Mathematics, Indian Institute of Technology Bhilai, 491002, Durg, Chhattisgarh, India pawan@iitbhilai.ac.in

J. C. de Albuquerqu Department of Mathematics, Federal University of Pernambuco 50670-901, Recife-PE, Brazil

josecarlos.melojunior@ufpe.br

J. L. Santos

Department of Mathematics, Federal University of Pernambuco 50670-901, Recife-PE, Brazil luando.brito@ufpe.br

V. M. Tripathi Department of Mathematics, Indian Institute of Technology Bhilai, 491002, Durg, Chhattisgarh, India vinayakm@iitbhilai.ac.in

In this talk, we present a class of Stein-Weiss coupled system in dimension $N \geq 2$ involving Δ_N - operator, where $\Delta_N u = \operatorname{div}(|\nabla u|^{N-2}\nabla u)$ is the *N*-Laplacian operator. We discuss both linear and nonlinear coupling cases. Assuming that the nonlinearities have critical exponential growth in the sense of Trudinger-Moser inequality, we study the existence of positive solutions for the coupled system. Moreover, uniform estimates, asymptotic behavior and regularity of the solutions enrich the study of the system. In our approach we introduce an alternative to the standard arguments based on Lions' vanishingnonvanishing and shifted sequences argument by utilizing a variant of Palais Principle of symmetric criticality.